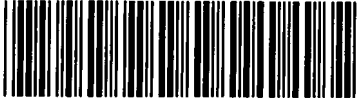


<b>Search Notes</b>  	<b>Application/Control No.</b>  10700466	<b>Applicant(s)/Patent Under Reexamination</b>  OHMI, TADAHIRO
	<b>Examiner</b>  Tran, Thien F	<b>Art Unit</b>  2811

SEARCHED			
Class	Subclass	Date	Examiner
257	325,347,374,410,411,501,506,510	5/21/2007	TT

SEARCH NOTES		
Search Notes	Date	Examiner
Search history printout	05/21/2007	TT
Interference search history printout	05/21/2007	TT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner